

This errata sheet provides updated information on known device issues affecting Stratix® IV E devices.

Stratix IV E Production Device Issues

Table 1 shows the specific issues and the affected Stratix IV E production devices.

Table 1. Stratix IV E Production Device Issues

Issue	Affected Devices	Planned Fix
M144K RAM Block Lock-up M144K RAM blocks may lock up if there is a glitch in the clock source.	All production devices	—
Stratix IV E Power-up Sequencing on Production Devices The device fails to power up and exit POR at low temperatures when V_{CC} is powered after V_{CCAUX} .	All production devices	—
Higher Power Supply Current During Power-Up for V_{CCPD} Higher power-up current requirements are needed for V_{CCPD} power supply.	All production devices	Refer to “Higher Power Supply Current During Power-Up for V_{CCPD} ” on page 5
DPA Misalignment Dynamic phase alignment (DPA) circuitry in Stratix IV E devices might get stuck at the initial configured phase or move to the optimum phase after a longer than expected period of time.	All production devices	For more information, refer to “DPA Misalignment” on page 8.

M144K RAM Block Lock-Up

M144K blocks may lock up if there is a glitch in the clock source when $rden$ equals 1. In the lock-up state, the RAM block does not respond to read or write operations and requires an FPGA reconfiguration to restore operation. The issue occurs within the M144K RAM in the Read Timer Trigger circuitry. A clock glitch may inadvertently freeze the Read Timer Trigger circuitry, locking the RAM block in its last operation. MLABs and M9K RAM blocks are not affected.

The workaround is to add clock-enable logic, an internal PLL, or clock-generation logic (for example, a clock divider). You can add clock-enable logic (internal or external) to disable RAM block operation until the clock is stable. You can also gate the clock internally or externally. If FPGA resources permit, you can use an internal PLL or clock-generation logic to ensure a stable clock source at the RAM block input.

The Read Timer circuitry makes RAM block operation independent of the input clock duty cycle, thus maximizing design performance. If you cannot provide a stable clock, use the DCD option in the Quartus® II software version 9.1 to work around this problem. When the M144K block uses the DCD option, it does not exhibit the lock-up behavior, but clock high-time requirements are increased and f_{MAX} performance is degraded.

If you cannot provide a stable clock input without glitches, perform the following steps to enable the DCD option in the Quartus II software:

1. On the Assignments menu, click **Settings**.
2. In the **Category** list, select **Fitter Settings**.
3. Click **More Settings**.
4. Under **Existing option settings**, set **M144K Block Read Clock Duty Cycle Dependency** to **On**.
5. Click **OK**.
6. Compile your design.

There is a **.qsf** variable that you can use instead of the previous instructions for making a global assignment.

DCD is on globally by adding the following line to the project's **.qsf** (the default is **Off**):

```
set_global_assignment -name  
M144K_BLOCK_READ_CLOCK_DUTY_CYCLE_DEPENDENCY ON
```

Alternatively, you can also apply this setting to individual M144K blocks with the Assignment Editor.

The global and per instance assignments can be mixed. For example, you can set DCD to **On** globally, but set it to **Off** for an instance. You can also only set it to **On** by instance.

Stratix IV E Power-up Sequencing on Production Devices

Stratix IV E devices might fail to power up correctly at low temperatures when the V_{CC} (0.9 V) power supply powers up after the V_{CCAUX} (2.5 V) power supply. This issue occurs because the FPGA device fails to exit power-on reset (POR), as indicated by the $nSTATUS$ pin being stuck low. Configuration cannot begin when the $nSTATUS$ pin is low.

The problem affects all Stratix IV E devices. Engineering sample devices are not affected.

Production devices must use the power-up sequence board design modifications to successfully power-up and exit POR on production devices, by fully powering V_{CC} before V_{CCAUX} begins to ramp. There is no dependency on the ramp rate for V_{CC} and V_{CCAUX} . The published ramp rate specifications still apply.



You can successfully use the hot socketing feature if you use the V_{CC} before V_{CCAUX} power sequence board design modification.

Contact Altera for Technical Support if you require assistance with implementing these board design changes.

Stratix IV E ES Device Issues

Table 2 shows the specific issues and which Stratix IV E ES devices are affected by each issue.

Table 2. Stratix IV E ES Family Issues

Issue	Affected Devices	Planned Fix
Remote System Upgrade Remote System Upgrade fails when loading an invalid configuration image.	EP4SE530 ES devices	Production devices
M9K/M144K RAM Block Lock-up M9K/M144K RAM blocks may lock up if there is a glitch in the clock source.	EP4SE530 ES devices	None
CRC Error Injection Feature The CRC Error Injection feature may not operate correctly.	EP4SE530 ES devices	Production devices
Higher Power Supply Current During Power-Up for V_{CCPD} Higher power-up current requirements are needed for V_{CCPD} power supply.	EP4SE530 ES devices	None
M144K Write with Dual-Port Dual-Clock Modes M144K RAM blocks may not operate correctly in dual-port dual-clock modes.	EP4SE530 ES devices	Production devices
Automatic Clock Switchover Automatic clock switchover feature may not operate correctly.	EP4SE530 ES devices	Production devices
CRC Error Detection Feature MLAB RAM blocks may not operate correctly with the CRC Error Detection feature enabled.	EP4SE530 ES devices	Production devices
Higher V_{CC} Power Supply Levels Stratix IV E ES devices require higher V_{CC} power supply levels.	EP4SE530 ES devices (all speed grades)	Production devices
I/O Jitter Stratix IV E ES devices may exhibit higher than expected jitter on all I/O pins.	EP4SE530 ES devices	Production devices
Higher Minimum f_{INPFD} Setting Stratix IV E ES devices may exhibit higher than expected PLL jitter at low f_{INPFD} settings.	EP4SE530 ES devices	Production devices
High I/O pin leakage current Top and bottom I/O banks show higher leakage than the published Stratix IV Data Sheet version 2.1 specifications.	EP4SE530 ES devices	EP4SE530 production devices
Higher standby current for V_{CC} power supply Higher than specified standby current on the V_{CC} supply.	EP4SE530 ES devices	EP4SE530 production devices
Reduced M9K/M144K performance Reduced M9K/M144K performance for Stratix IV E ES devices.	EP4SE530 ES devices	EP4SE530 production devices
DPA misalignment Dynamic phase alignment (DPA) circuitry in Stratix IV E ES devices might get stuck at the initial configured phase or move to the optimum phase after a longer than expected period of time.	EP4SE530 ES devices	For more information, refer to "DPA Misalignment" on page 8.

Remote System Upgrade

The remote system upgrade feature does not operate correctly when you initiate a reconfiguration cycle from a factory configuration image to an invalid application configuration image. In this scenario, Stratix IV GX and Stratix IV E devices fail to revert to the factory configuration image after a configuration error is detected while loading the invalid application configuration image. The failure is indicated by a continuous toggling of the nSTATUS pin.

In correct operation, Stratix IV GX and Stratix IV E devices should revert to the factory configuration image after a configuration error is detected with the invalid configuration image.



An invalid application configuration image is classified as one of the following:

- A partially programmed application configuration image
- A blank application configuration image
- An application configuration image assigned with a wrong start address

The remote system upgrade feature works correctly with all other reconfiguration trigger conditions.

This issue is addressed by using the updated ALTREMOTE_UPDATE megafunction and will be available in the Quartus® II software version 9.1, or contact Altera technical support for the software patch available with the Quartus II software version 9.0 SP2.

M9K/M144K RAM Block Lock-up

The M9K and M144K blocks can lock up if the clock source glitches when `rden=1`, which can occur if the clock source is not from a PLL. In this state, a RAM block no longer responds to read or write operations and requires an FPGA reconfiguration to restore operation. The issue occurs in the Read Timer Trigger circuitry, where a glitch-prone non-PLL clock may inadvertently freeze the Read Timer Trigger circuitry, locking the RAM block in its last operation. All RAM block modes are affected. MLABs are not affected.

The workaround is to add clock-enable logic, an internal PLL, or clock generation logic (for example, a clock divider). You can add clock-enable logic (internal or external) to disable RAM block operation until the clock is stable. You can also gate the clock internally or externally. If FPGA resources permit, you can use an internal PLL or clock generation logic to ensure a stable clock source at the RAM block input.

CRC Error Injection Feature

The CRC Error Injection feature on Stratix IV E ES devices may not operate correctly when running the `EDERROR_INJECT JTAG` instruction. The `CRC_ERROR` output status pin may remain low, incorrectly indicating no CRC errors.

This issue only occurs with the error injection block and is fixed in production devices. The CRC Error Detection feature operates correctly as expected, and is not affected by this issue.

If you need to use the CRC Error Injection feature with ES devices, contact Altera® Technical Support.

Higher Power Supply Current During Power-Up for V_{CCPD}

Stratix IV E ES devices require higher power-up current levels for the V_{CCPD} power supply than presently specified. The Quartus® II software version 9.0 and the Early Power Estimator (EPE) version 9.0 reflect production devices only.

Stratix IV E ES device functionality is not affected by this issue, even if your V_{CCPD} power supply is designed with output current levels below what the Quartus II software and/or EPE specify. Stratix IV E ES devices will power-up and operate correctly as expected, provided the supplies power up monotonically and the minimum voltage requirement is met. V_{CCPD} must meet the minimum power supply voltage requirement for the device to exit power-on reset (POR). After the device exits POR, the V_{CCPD} current requirements return to what is reported by Altera's power estimation tools. Overall thermal power and operating current levels are not affected by this issue.

If there are other devices on the board that share the V_{CCPD} power supply, you can use the Quartus II software and/or the EPE to estimate power supply current requirements. This analysis may be needed if the other devices on the board have stringent power supply integrity requirements. Use the EPE version 9.0.1 to determine higher power-up current requirements for the V_{CCPD} power supply for Stratix IV E ES devices.

There is no planned fix for the higher power-up current requirements. These currents will be reflected as minimum requirements for production devices in future versions of the Quartus II software and the EPE.

M144K Write with Dual-Port Dual-Clock Modes

M144K RAM blocks in dual-port dual-clock modes may fail to operate correctly, affecting applications such as DCFIFO memories, where data is transferred between two separate clock domains.

If you are using Stratix IV E ES devices with the Quartus II software version 9.0, you must recompile your design and manually avoid all use of M144K RAM blocks in dual-port dual-clock modes. The Quartus II software version 9.0 SP1 will automatically disable use of dual-port dual-clock modes in all M144K RAM blocks. In both cases, your design's usage of M9K RAM blocks may increase as a result.

This issue is fixed in production devices.



You can download a software patch to help with M144K RAM blocks in dual-port dual-clock mode failure at:

http://www.altera.com/support/kdb/solutions/rd04092009_699.html

Automatic Clock Switchover

The PLL Automatic Clock Switchover feature may fail to operate correctly on Stratix IV E ES devices when the two clocks are running different frequencies. If both clocks are running at the same frequency, there is no impact to your design. The following modes are affected:

- Automatic
- Automatic with Manual Override

You may observe two possible issues:

- Switchover from `inclk0` to `inclk1`, even though `inclk0` is active (and vice-versa)
- `clkbad[0,1]` status signals may glitch, even if the input clocks are active



Manual clock switchover mode operates correctly as expected and is not affected.

This issue is fixed in production devices.

CRC Error Detection Feature

The CRC Error Detection feature, when single event upset (SEU) detection is enabled, may cause the MLAB RAM blocks to operate incorrectly in Stratix IV E ES devices. Write operations in MLAB RAM blocks are affected with all CRC Error Detection divisor settings.



The CRC Error Detection feature operates correctly as expected. FPGA configuration bits are not affected by this issue.

Disabling the CRC Error Detection feature in your design compilation with the Quartus II software will prevent this issue from occurring in ES devices.

This issue is fixed in production devices.



You can download a software patch to help with the CRC Error Detection feature issue at: http://www.altera.com/support/kdb/solutions/rd04092009_699.html

Higher V_{CC} Power Supply Levels

Stratix IV E ES devices require higher V_{CC} power supply levels (refer to [Table 3](#)).

Table 3. Power Supply Levels for Stratix IV E ES Devices

Power Supply	Power Supply Level (V)	Description
V_{CC}	0.95	Core voltage and periphery circuitry power supply
V_{CCD_PLL}	0.95	PLL digital power supply

EP4SE530 ES devices require V_{CC} and V_{CCD_PLL} power supplies set to 0.95 V +/- 0.03 V for all speed grades.

Use the Stratix IV E PowerPlay Early Power Estimator version 9.0.1 to estimate current and power/thermal requirements for Stratix IV E ES devices with the required higher power supply levels. The Stratix IV E PowerPlay Early Power Estimator version 9.0 reflects current and power estimates for production devices at data sheet specifications only.

Production devices will not operate at these higher power supply levels. If needed, design your power supplies to support dropping power supply levels back to data sheet specification for production devices.

There are no reliability issues with Stratix IV E ES devices at these higher power supply levels.

I/O Jitter

Stratix IV E ES devices may exhibit $\pm \sim 100$ ps higher than expected jitter on all I/O pins. The actual amount of additional jitter is application and toggle-rate dependent.

Altera fixed the issue in production devices, which meets all current jitter specifications.

If you are using ES devices, you need to account for this additional timing uncertainty in all I/O timing closure budgets.

Higher Minimum f_{INPFD} Setting

Stratix IV E ES devices may exhibit higher than expected PLL jitter at low f_{INPFD} settings. Raising the minimum f_{INPFD} to 25 MHz removes the additional PLL jitter in ES devices.

Altera fixed the issue in production devices, which meets the current f_{INPFD} minimum of 5 MHz.

If you are using ES devices, review your f_{INPFD} settings by searching under “Nominal PFD Frequency” in each PLL section of your `.fit.rpt` compilation report file. If needed, recompile your design in the Quartus II software with modified PLL settings to achieve the higher minimum f_{INPFD} .



For more information about the ALTPLL megafunction, refer to the [Quartus II Handbook](#) or the [Phase-Locked Loops \(ALTPLL\) Megafunction User Guide](#).

High I/O Pin Leakage Current

Top and bottom I/O pin leakage current is higher for Stratix IV E ES devices than production devices. Side I/O banks are not affected. Refer to [Table 4](#) for Stratix IV E ES device I/O pin leakage current on top and bottom I/O banks.

Table 4. I/O Pin Leakage Current for Top and Bottom I/O Banks

Temperature	I/O Bank Voltage (V)					Units
	3.0	2.5	1.8	1.5	1.2	
25°C	35	25	15	11	9	μA
85°C	140	100	60	45	35	μA

These I/O pin leakage current values apply to ES silicon only and not to production silicon.

Higher Standby Current for V_{CC} Power Supply

You can expect to see higher standby I_{CC} values on the V_{CC} power supply for Stratix IV E ES devices than indicated in the Quartus II software version 9.0 and the Stratix IV E PowerPlay Early Power Estimator (EPE) version 9.0. The higher standby I_{CC} current for the V_{CC} power supply is fixed in production devices.

Use the Stratix IV E PowerPlay Early Power Estimator version 9.0.1 to estimate current and power/thermal requirements for the Stratix IV E ES device. The Stratix IV E PowerPlay Early Power Estimator version 9.0 will not be updated with these higher standby current values.

Reduced M9K/M144K Performance

M9K/M144K f_{MAX} and t_{CO} performance for Stratix IV E ES devices may be lower than indicated in the Quartus II software version 8.1. Compile your design in the Quartus II software version 9.0 to estimate the impact on your design.

DPA Misalignment

Stratix IV E ES DPA circuitry for EP4SE530 ES devices occasionally becomes stuck at the initial configured phase or takes significantly longer than expected to select the optimum phase. A non-ideal phase may result in data bit errors, even after the DPA lock signal has gone high. Resetting the DPA circuit may not alleviate the problem; in fact, resetting it might trigger the problem. LVDS receivers configured in DPA mode are affected. LVDS receivers configured in Soft CDR mode with 0 PPM difference (synchronous interface) are also affected.

For applications with flexibility in the choice of training patterns, Altera recommends you choose bit sequences with more data transitions and a non-cyclical pattern similar to a PRBS or K28.5 code sequence.

For applications using a fixed, cyclical, or data transition sparse training pattern (for example, if you are using the SPI 4.2 protocol, which specifies a training pattern of ten 0s and ten 1s), turn on the **DPA PLL Calibration** feature (available in the Quartus II software version 9.0) in the ALTLVDS MegaWizard Plug-In Manager.



There are two caveats when enabling the **DPA PLL Calibration** feature:

- PLL merging (merging RX and RX or merging RX and TX PLL) is not automatically supported by the ALTLVDS megafunction; use the **external PLL** option to handle PLL merging separately.
- Timing for all PLL outputs is pulled in by 1/4 of the voltage controlled oscillator (V_{CO}) phase during the PLL calibration process. This must be taken into account for external I/O pin timing interfaces and for clock domain transfers (without a FIFO) when the clocks are not all from this same PLL.



For more information about the **DPA PLL Calibration** feature, refer to the *SERDES Transmitter/Receiver (ALTLVDS) Megafunction User Guide* planned release corresponding to the Quartus II software version 9.0. Until the User Guide is updated, in the interim, contact the Altera mySupport page at www.mysupport.altera.com.

Document Revision History

Table 5 shows the revision history for this Errata Sheet.

Table 5. Document Revision History

Date and Document Version	Changes Made
January 2010, v2.1	Updated “Stratix IV E Power-up Sequencing on Production Devices”. Added “DPA Misalignment” section to production devices.
November 2009, v2.0	Added: <ul style="list-style-type: none"> ■ “Stratix IV E Production Device Issues” ■ “M144K RAM Block Lock-Up” ■ “Stratix IV E Power-up Issue on Production Devices” Updated the following with link to software patch: <ul style="list-style-type: none"> ■ “M144K Write with Dual-Port Dual-Clock Modes” ■ “CRC Error Detection Feature” Updated with fix in “Automatic Clock Switchover”.
August 2009, v1.1	Added “Remote System Upgrade”
June 2009, v1.0	<ul style="list-style-type: none"> ■ M9K/M144K RAM Block Lock-up ■ CRC Error Injection Feature ■ Higher Power Supply Current During Power-Up for V_{CCPD} ■ M144K Write with Dual-Port Dual-Clock Modes ■ Automatic Clock Switchover ■ CRC Error Detection Feature ■ Higher V_{CC} Power Supply Levels ■ I/O Jitter ■ Higher Minimum f_{INPFD} Setting ■ High I/O Pin Leakage Current ■ Higher Standby Current for V_{CC} Power Supply ■ Reduced M9K/M144K Performance ■ DPA Misalignment



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